## FEATURES

## Interfaces, amplifies, \& filtersanalog input voltages. Narrow-bandwidth (3Hz) single-channel single conditioning. <br> Module provides simultaneous precision voltage and current outputs. <br> Module circuitry can withstand 220 v rms at the input screwterminals <br> Current output withstands 130 V rms without damage. <br> All 3B30 \& 3B31 series modules are mix-and-match and Hot Swappable

## APPLICATIONS

## Industrial signal conditioning Industrial signal isolation Industrial signal filtering

## PRODUCT OVERVIEW

The 3B Series of Signal Conditioning I/o Subsystems provide a low-cost, versatile method of transferring analog transducer signals to a data acquisition, monitoring or control system without the inherent noise, non-linearity, drift and extraneous voltages. The modules are designed to directly accept analog signals from Thermocouples, RTD's, AC and DC Strain Gages, Torque Transducers, Frequency Transducers, LVDTs, millivolt or process current signals. The modules amplify, isolate, linearize and convert the transducer output signals to standardized analog inputs for high-level analog I/O subsystems. The 3B Series Subsystem consists of a 10 " relay rack with universal mounting backplane and a family of plug-in (up to 16 per rack) input and output signal conditioning modules.

Eight and four channel backplanes are also available. Each backplane incorporates screw terminals for sensor inputs and current outputs and a 26 -pin connector for high-level singleended voltage outputs to the user's equipment.

The input modules feature complete signal conditioning circuitry optimized for specific sensors or analog signals and provide two simultaneous high-level analog outputs: 0 to +10 V (or $\pm 10 \mathrm{~V}$ ) and $4-20 \mathrm{~mA}$ (or 0-20 mA).

## Rev. 0

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## FUNCTIONAL BLOCK DIAGRAM



Figure 1. 3B30 \& 3B31 Functional Block Diagram
Output modules accept 0 to +10 V (or $\pm 10 \mathrm{~V}$ ) single-ended signals and provide an isolated $4-20 \mathrm{~mA}$ (or 0-20 mA) process signal. All modules feature a universal pin-out and may be readily hot-swapped under full power and interchanged without disrupting field wiring.

The Analog Devices 3B Series Signal Conditioning Subsystem is designed to easily handle signal conditioning problems in measurement and control applications. Some typical uses are in microcomputer-based data acquisition systems, programmable controllers, analog recorders, dedicated control systems, and any other applications where monitoring of temperature, pressure, flow and analog signals are required. Since each input module features two simultaneous outputs, the voltage output can be used to provide an input to a microprocessor-based data acquisition or control system while the current output can be used for analog transmission, operator interface, or an analog backup system.

Each input module is a single-channel signal conditioner which plugs into a socket on the backplane and accepts its signal from the input screw terminals. All input modules provide input protection, amplification and filtering of the input signal, accuracy of $\pm 0.1 \%$, low drift of $\pm 1 \mathrm{uV} /{ }^{\circ} \mathrm{C}$ (low-level input modules), and feature two high-level analog outputs that are compatible with most process instrumentation. The isolated input modules also provide $\pm 1500 \mathrm{~V}$ peak isolation.

The choice of a specific 3B module depends upon the type of input signal. Input modules are available to accept millivolt, volt, process current, thermocouple, RTD, AC and DC strain gage, frequency and LVDT inputs. The voltage output of each module is available from the system I/O connector while the current output is available on the output screw terminals.

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## GENERAL DESCRIPTION

The 3B30 \& 3B31 are narrow-bandwidth (3Hz) single-channel signal conditioning modules which amplify, isolate, filter and protect analog input voltages and provide simultaneous precision voltage and current outputs. Each module performs complete signal conditioning, including isolating ( +1500 V peak input-to-output and power) and protecting their computer side outputs from damage and loss of signal integrity, and shielding their inputs from damage from field-side over-voltage faults up to 220 V rms. The current output withstands 130 V rms without damage and interfaces user equipment through screw terminals located on the 3B Series backplane. Each plug-in, mix-andmatch, hot-swappable module is easily field calibrated via frontpanel zero and span adjustments for both voltage and current outputs.

3B Series Custom-Ranging Program - Externallyprogrammable Models 3B30-00 and 3B31-00, enable the user to configure a special input range by using the optional plug-on AC1310 ranging card, which houses user-supplied resistors to determine zero and span. To facilitate selecting resistors, a Windows program, 3B-CUSTOM, calculates resistor values based on the user-desired input/output ranges.

A chopper-stabilized low-drift $\left( \pm 1 \mathrm{uV} /{ }^{\circ} \mathrm{C}\right)$ input amplifier assures stable long-term stability. At the amplifier input, a stable, zero-scale input voltage is subtracted from the input signal to
set the zero-scale value. Zero suppression can exceed $100 \%$ of the input range. This is ideal fro expanded-scale applications requiring high-resolution measurement of a selected portion of an input signal. For users convenience, the zero and span can be factory configured to meet custom range needs (Models 3B30CUSTOM and 3B31-CUSTOM) or can be externally programmed (Models 3B30-00 and 3B31-00) via user supplied resistors inserted in the optional AC1310 plug-on ranging card. Internal low-pass filtering with a 4 Hz cutoff ( -3 dB ) two-pole Butterworth filter enhances both 60 dB normal-mode and 160 dB common-mode rejection at $50 / 60 \mathrm{~Hz}$, enabling accurate measurement of small signals in high electrical noise.

Signal isolation is accomplished by transformer coupling with a proprietary modulation technique for linear, stable and reliable performance. The differential input circuit on the field side is fully floating, eliminating the need for any input grounding. A demodulator on the computer side of the signal transformer recovers the original signal, which is then filtered and buffered to provide a low-noise, low-impedance output voltage; this output also drives a voltage-to-current (V/I) converter to provide a simultaneous current output for interfacing versatility.


Figure 2

## 3B30 and 3B31 Models Available

| Model | Input Range |
| :---: | :---: |
| 3B30-00 | Externally Programmable ${ }^{2}$ |
| 3B30-01 | -10 mV to +10 mV |
| 3B30-02 | -50 mV to +50 mV |
| 3B30-03 | -100 mV to +100 mV |
| 3B30-Custom | * |
| 3B31-00 | -1 V to +1 V |
| 3B31-01 | -5 V to +5 V |
| 3B31-02 | -10 V to +10 V |
| 3B31-03 | $*$ |

Output Ranges ${ }^{1}$
-10 V to $+10 \mathrm{~V} \& 0 \mathrm{~mA}$ to 20 mA
-10 V to $+10 \mathrm{~V} \& 0 \mathrm{~mA}$ to 20 mA
-10 V to $+10 \mathrm{~V} \& 0 \mathrm{~mA}$ to 20 mA
-10 V to $+10 \mathrm{~V} \& 0 \mathrm{~mA}$ to 20 mA
$*$
-10 V to $+10 \mathrm{~V} \& 0 \mathrm{~mA}$ to 20 mA
-10 V to $+10 \mathrm{~V} \& 0 \mathrm{~mA}$ to 20 mA
-10 V to $+10 \mathrm{~V} \& 0 \mathrm{~mA}$ to 20 mA
-10 V to $+10 \mathrm{~V} \& 0 \mathrm{~mA}$ to 20 mA
-10 V to $+10 \mathrm{~V} \& 0 \mathrm{~mA}$ to 20 mA
${ }_{2}^{1}$ Output current range may be user programmed to 4 mA to 20 mA using jumper supplied.
${ }^{2}$ Requires AC1310 ranging card.

* Custom Input/Output ranges are available. Refer to configuration guide.


## 3B30 and 3B31 Specifications <br> (typical @ $+25^{\circ} \mathrm{C}$ and $\pm 15 \mathrm{~V} \mathrm{dc}$, and +24 V dc Power)

| Description | Model 3B30 | Model 3B31 |
| :---: | :---: | :---: |
|  | Input Range |  |
| Standard Ranges | $\pm 10 \mathrm{mV}$ to $\pm 100 \mathrm{mV}$ | $\pm 1 \mathrm{~V}$ to $\pm 10 \mathrm{~V}$ |
| Custom Ranges | $\pm 5 \mathrm{mV}$ to $\pm 500 \mathrm{mV}$ | $\pm 0.5 \mathrm{~V}$ to $\pm 20 \mathrm{~V}$ |
|  | Output Range |  |
| Voltage ( $\mathrm{R}_{\mathrm{L}}>2 \mathrm{~K} \Omega$ ) | -10 V to +10 V | * |
| Current ( $\mathrm{R}_{\mathrm{L}}=0$ to $850 \Omega$ ) ${ }^{1}$ | 4 mA to 20 mA or 0 mA to 20 mA | * |
| Maximum Current Output Span | 0 mA to 31 mA | * |
|  | Accuracy ${ }^{2}$ |  |
| Initial @ $+25^{\circ} \mathrm{C}$ | $\pm 0.1 \%$ Span | * |
| Nonlinearity | $\pm 0.01 \%$ Span | * |
|  | Stability vs. Temperature |  |
| Voltage Output |  |  |
| Zero | $\pm 1 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C}$ (RTI) | $\pm 25 \mathrm{ppm}$ of Span/ ${ }^{\circ} \mathrm{C}$ |
| Span | $\pm 25 \mathrm{ppm}$ of Reading $/{ }^{\circ} \mathrm{C}$ | * |
| Current Output ${ }^{3}$ |  |  |
| Zero | $\pm 25 \mathrm{ppm}$ of $\mathrm{Span} /{ }^{\circ} \mathrm{C}$ | * |
| Span | $\pm 25 \mathrm{ppm}$ of Reading $/{ }^{\circ} \mathrm{C}$ | * |
| Zero and Span Adjustment Range ${ }^{4}$ | $\pm 5 \%$ of Span | * |


| Input Bias Current | $+3 \mathrm{nA}$ | * |
| :---: | :---: | :---: |
| Input Resistance | $15 \mathrm{M} \Omega$ | $650 \mathrm{k} \Omega$ |
| Noise |  |  |
| Input, 0.1 Hz to 10 Hz Bandwidth | $0.2 \mu \mathrm{~V} \mathrm{rms}$ | * |
| Output, 100 kHz Bandwidth | $50 \mu \mathrm{Vrms}$ | * |
| Bandwidth, -3 dB | 3 Hz | * |
| Output Rise Time, 10\% to 90\% Span | 200 ms | * |
| Common-Mode Voltage (CMV) |  |  |
| Input-to-Output, Continuous | $\pm 1500 \mathrm{~V}$ peak, maximum | * |
| Transient | ANSI/IEEE C37.90.1-1989 | * |
| Common Mode Rejection (CMR) |  |  |
| $1 \mathrm{k} \Omega$ Source Imbalance, $50 / 60 \mathrm{~Hz}$ | 160 dB | $\begin{aligned} & 160 \mathrm{~dB} \\ & 150 \mathrm{~dB}(3 \mathrm{~B} 31-02) ; 145 \mathrm{~dB}(3 \mathrm{~B} 31-03) \end{aligned}$ |
| Normal Mode Rejection, 50/60 Hz | 60 dB | * |
| Input Protection |  |  |
| Continuous | 220 V rms maximum | * |
| Transient | ANSI/IEEE C37.90.1-1989 | * |
| Voltage Output Protection | Continuous Short to Ground | * |
| Current Output Protection | 130 V rms, continuous | * |
| Power Supply Voltages ${ }^{5}$ |  |  |
| $\pm 15 \mathrm{~V}$ dc Supplies |  |  |
| Rated Operation | $\pm(11.5 \mathrm{~V}$ dc to 16.5 V dc$)$ | * |
| Current | $\pm 10 \mathrm{~mA}$ | * |
| Sensitivity | $\pm 0.01 \%$ span/V | * |
| +24 V dc Loop Supply |  |  |
| Rated Operation | +12 V dc to +30 V dc | * |
| Current | +27 mA @ $\mathrm{l}_{\text {out }}=20 \mathrm{~mA}$ | * |
| Sensitivity | $\pm 0.0002 \%$ span/V | * |
| Mechanical Dimensions | $\begin{aligned} & 3.15 " \times 3.395 " \times 0.775 " \\ & 80.0 \mathrm{~mm} \times 86.2 \mathrm{~mm} \times 19.7 \mathrm{~mm}) \end{aligned}$ | * |
|  | Environmental |  |
| Temperature Range |  |  |
| Rated Performance | $-25^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | * |
| Storage | $-55^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | * |
| Relative Humidity, 24 hours | 0 to $95 \%$ @ $+60^{\circ} \mathrm{C}$ non-condensing | * |
| RFI Susceptibility | $\pm 0.5 \%$ Span error @ $400 \mathrm{MHz}, 5 \mathrm{Watt}, 3 \mathrm{ft}$ | * |
| * Specifications same as model 3B30. |  |  |
| ${ }^{1}$ For a 0 to 20 mA range, a typical minimum output current is $10 \mu \mathrm{~A}$. |  |  |
| ${ }^{2}$ Includes the combined effects of repeatability, hysteresis, and nonlinearity. |  |  |
| ${ }^{3}$ With respect to the voltage output. |  |  |
| ${ }^{4} \mathrm{~A}$ wide range of custom zero suppression and ${ }^{5}+24 \mathrm{~V}$ dc loop power is required for driving the voltage output is used, loop power is not requir Specifications subject to change without notice. | lable with the 3B30-00 and 3B31-00 models, using ut at loads up to $850 \Omega$. If a current output load of 4 | nging card. <br> applied, +15 V dc is sufficient for loop power |

## PIN CONFIGURATIONS AND FUNCTIONAL DESCRIPTIONS



Figure 3 3B30 \& 3B31Input Field Connections
Table 1. Pin Function Descriptions-

| Pin No. | Description |
| :--- | :--- |
| 1 | $\mathrm{n} / \mathrm{c}$ |
| 2 | HI |
| 3 | LO |
| 4 | $\mathrm{n} / \mathrm{c}$ |



Figure 4 . Model 3B Series Module, with pin-out assignments.

## ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.

## OUTLINE DIMENSIONS



Figure 5. Outline Dimensions

NOTES

## NOTES


[^0]:    One Technology Way, P.O. Box 9106, Norwood, MA 02062-9106, U.S.A.
    Tel: 781.329.4700
    www.analog.com
    Fax: 781.326.8703 © 2004 Analog Devices, Inc. All rights reserved.

